

Notice of References Cited	Application/Control No. 10/603,613	Applicant(s)/Patent Under Reexamination MIYAZAKI, TAKESHI	
	Examiner Sophia S. Chen	Art Unit 2852	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,444,518	08-1995	Hashiguchi et al.	399/1(X)
	B	US-5,570,451	10-1996	Sakaizawa et al.	399/2
	C	US-5,729,785	03-1998	Sakaizawa et al.	399/2
	D	US-5,761,565	06-1998	Baker et al.	399/2
	E	US-2002/0171716 A1	11-2002	Jeanmaire, David L.	347/74
	F	US-2003/0063912 A1	04-2003	Miyazaki et al.	399/2
	G	US-6,588,888	07-2003	Jeanmaire et al.	347/77
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	04-069694	03-1992	Japan	Nagano	-----/-----
	O	05-031966	02-1993	Japan	Moriguchi et al.	-----/-----
	P	07-276782	10-1995	Japan	Ozeki et al.	-----/-----
	Q	08-185077	07-1996	Japan	Mikami	-----/-----
	R	2002-361939	12-2002	Japan	Umeda et al.	-----/-----
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.